



SAND2014-15941PE

# Experimental Capabilities and Challenges for Dynamic Material Properties on the Z Machine

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Fundamental Science on Z Workshop  
July 23, 2014



Sandia National Laboratories

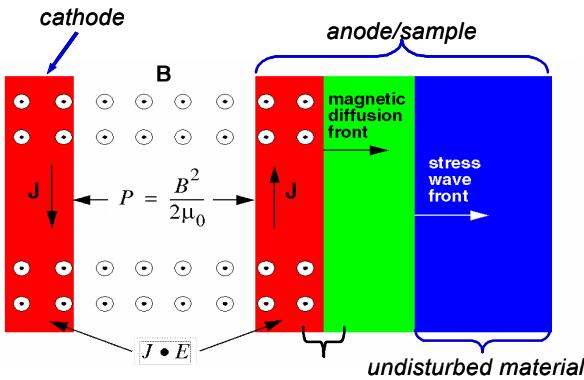


# Outline



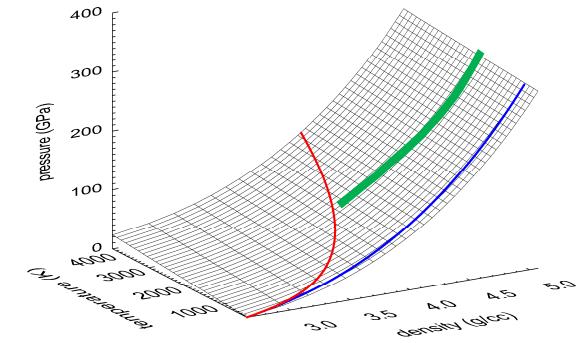
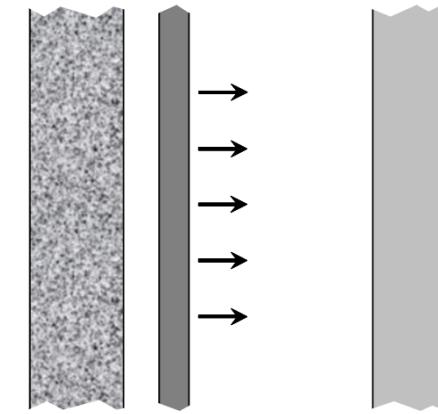
## Z Machine Overview

## Shock Compression



## Ramp Compression

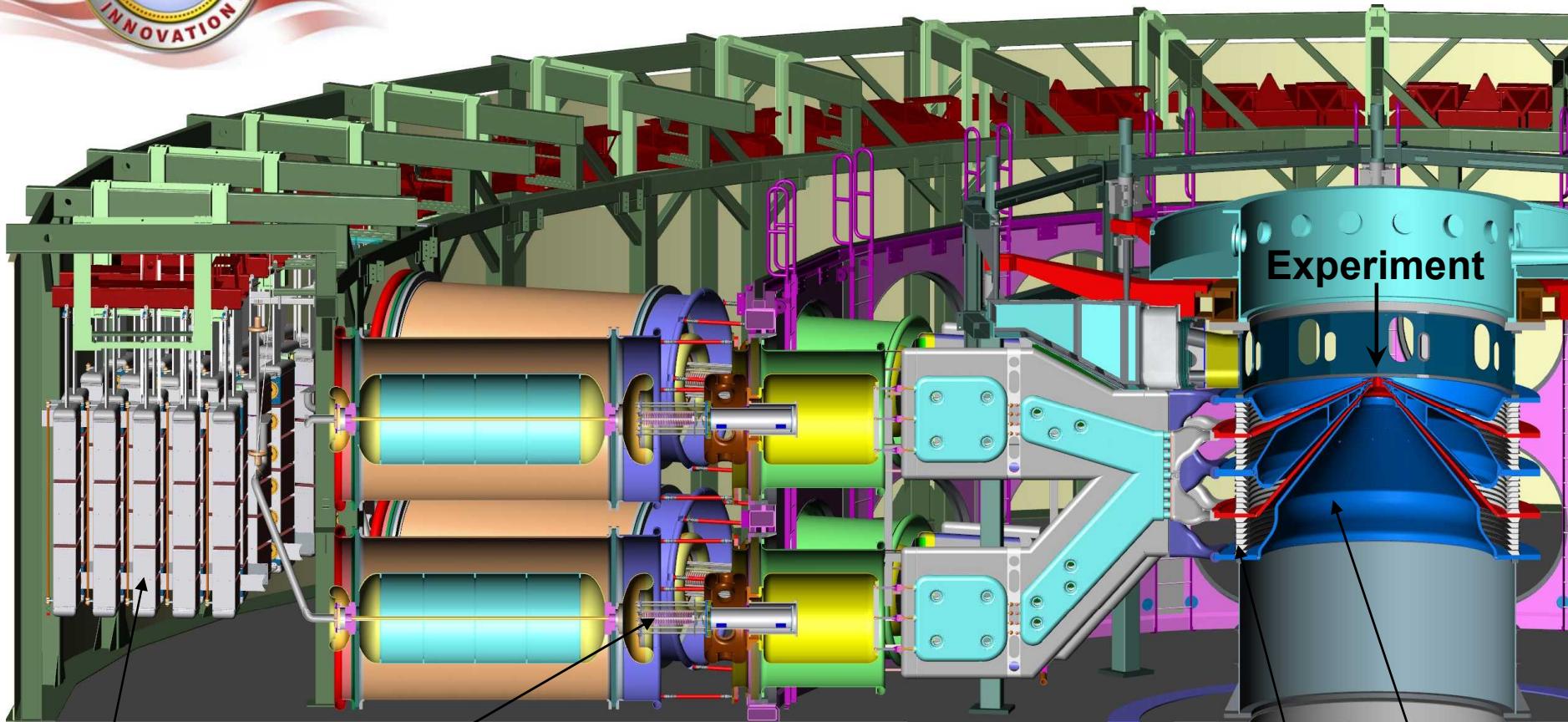
## Shock-Ramp Compression



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# The Sandia Z Machine



Marx generator

laser-triggered  
gas switch

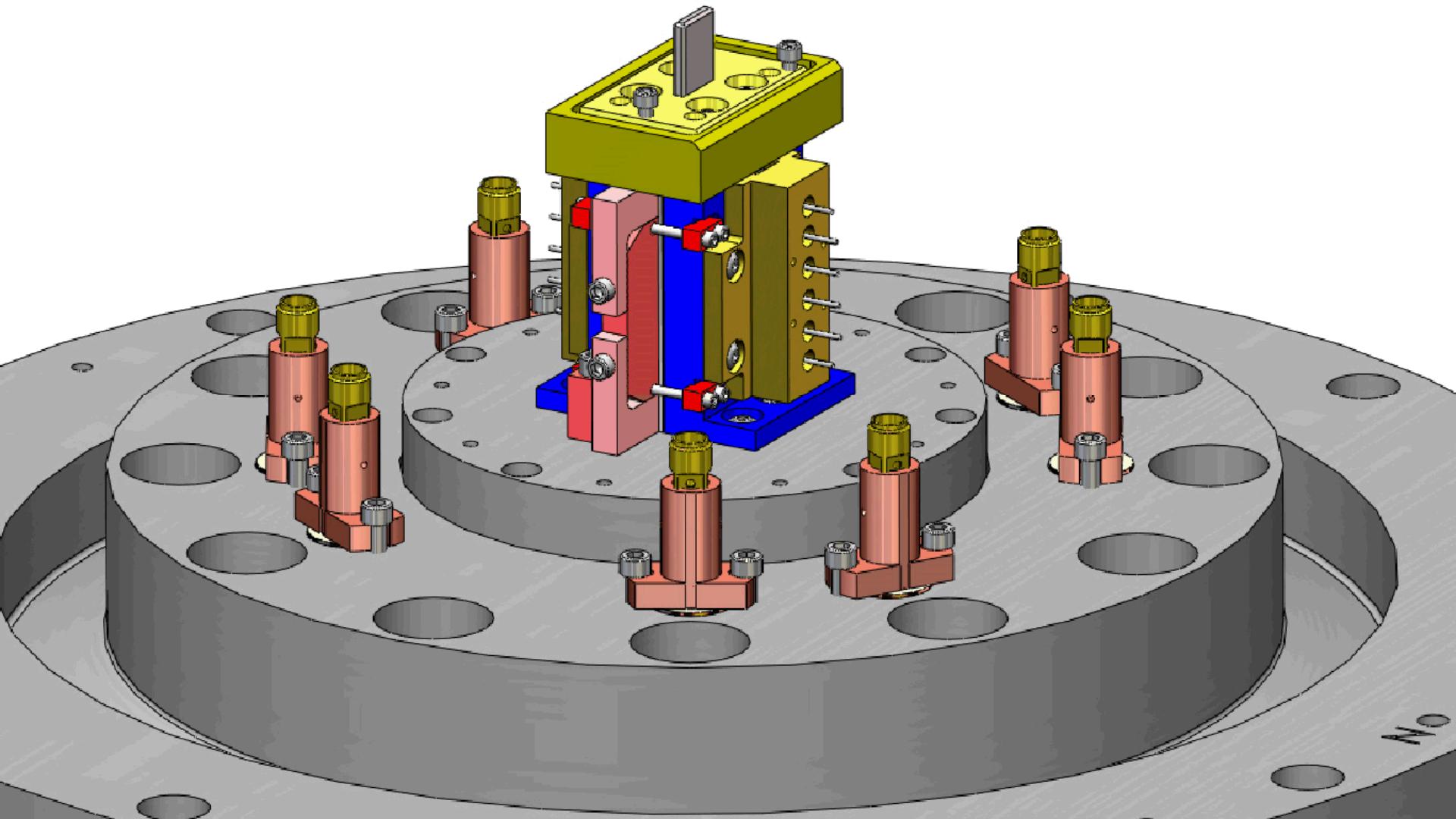
**22 MJ stored energy**  
**~25 MA peak current**  
**~200-600 ns rise time**

insulator  
stack

magnetically  
insulated  
transmission  
lines

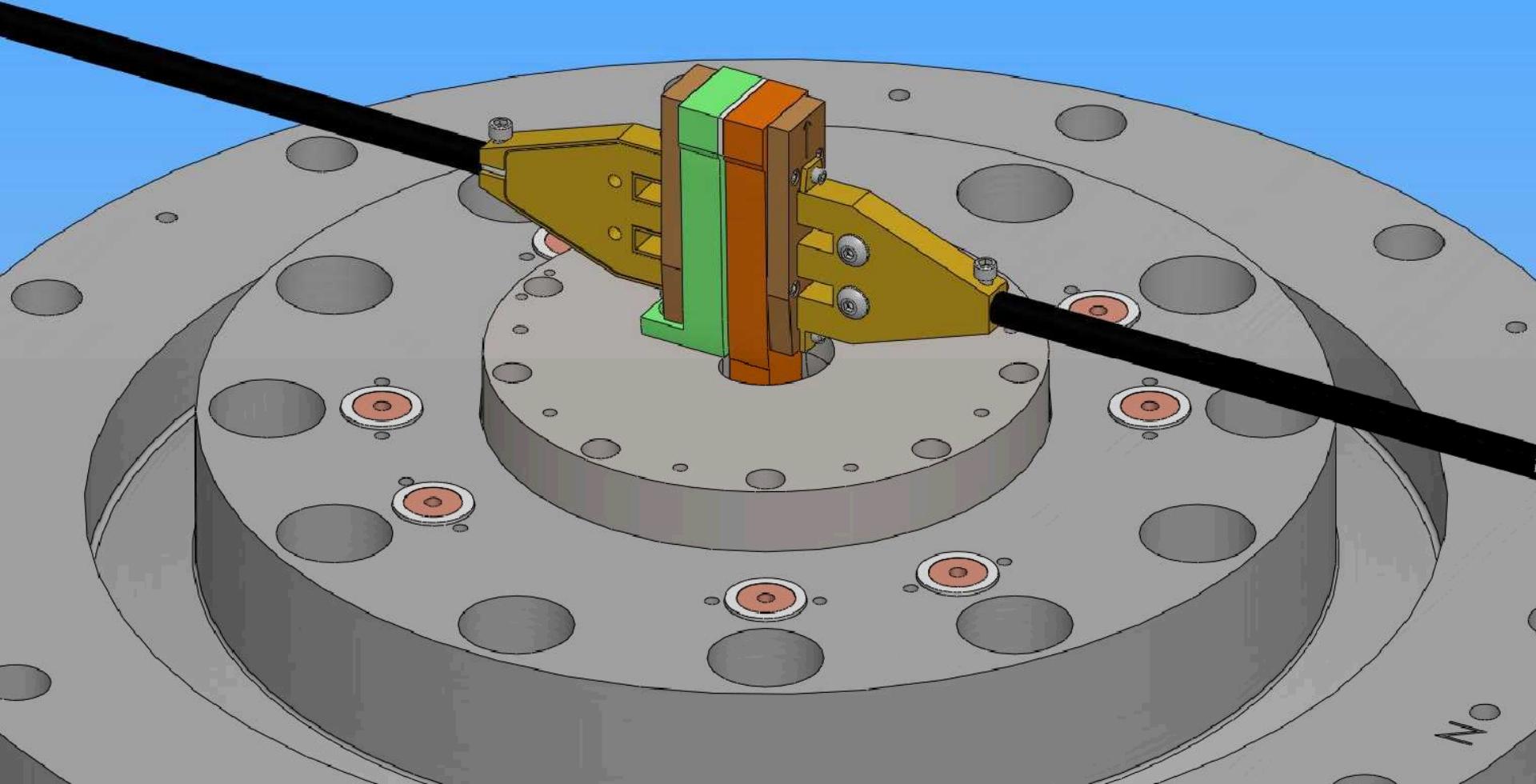


# Typical coaxial load for multi-Mbar shock compression experiments on Z





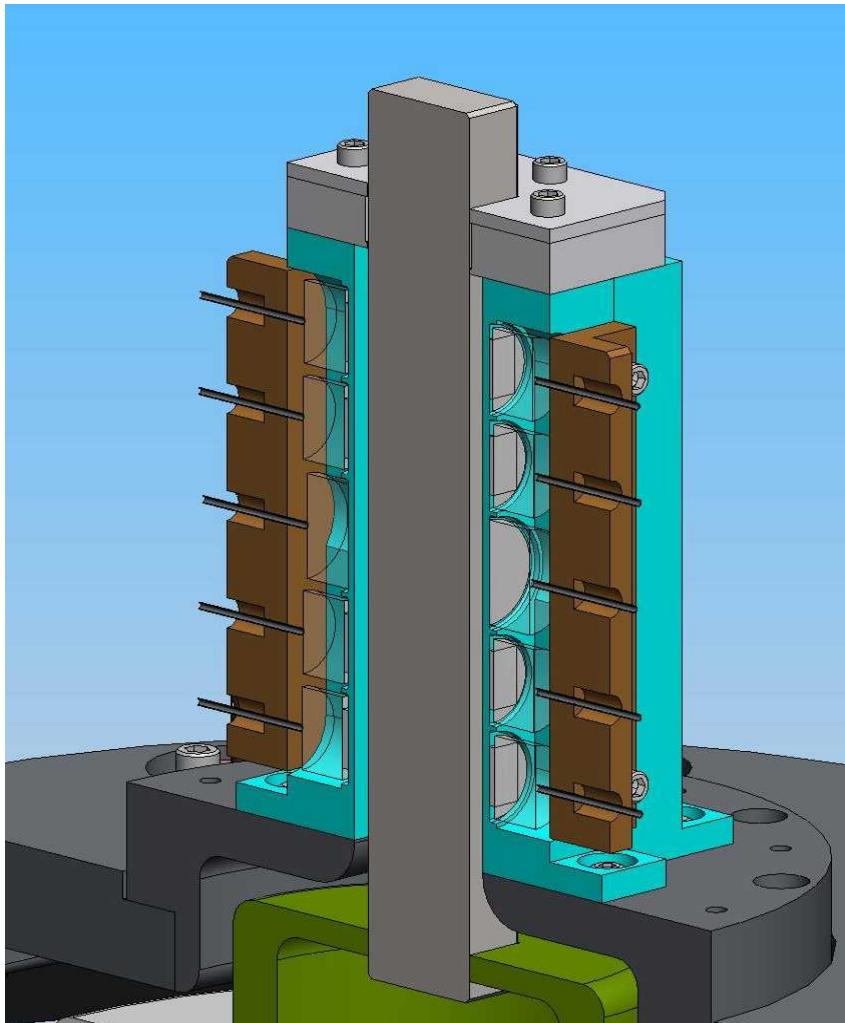
# Typical stripline load for multi-Mbar ramp compression experiments on Z



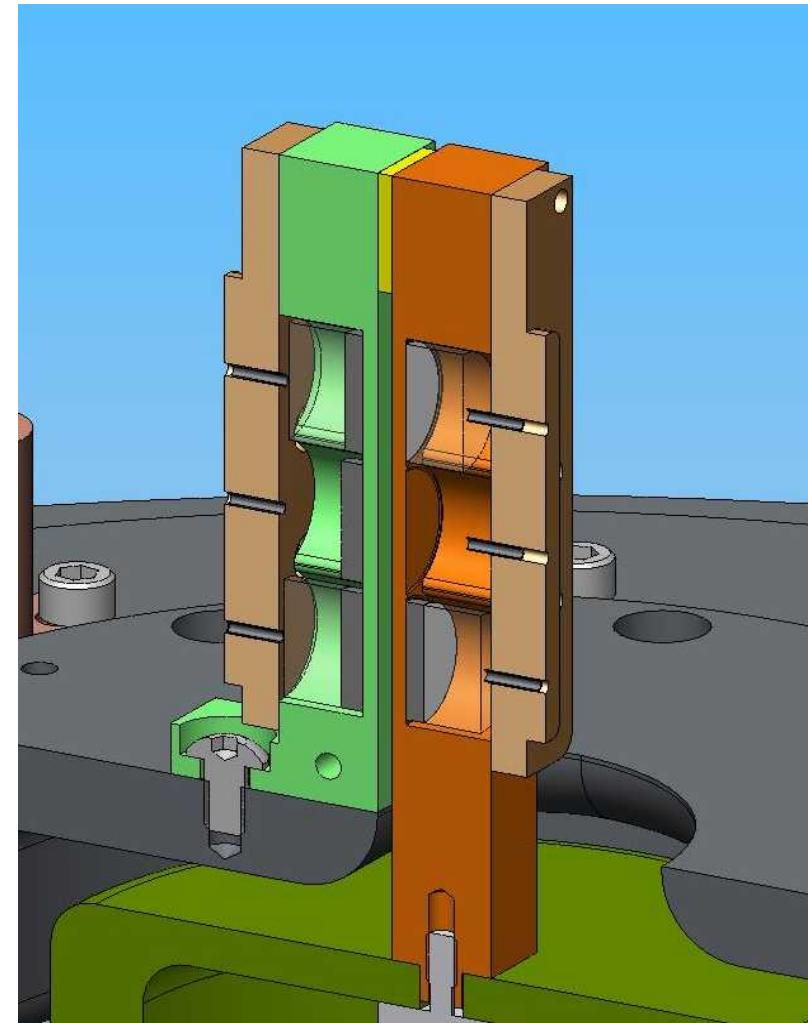


Two different load designs have been used for material dynamics experiments on Z

**Co-axial**



**Stripline**

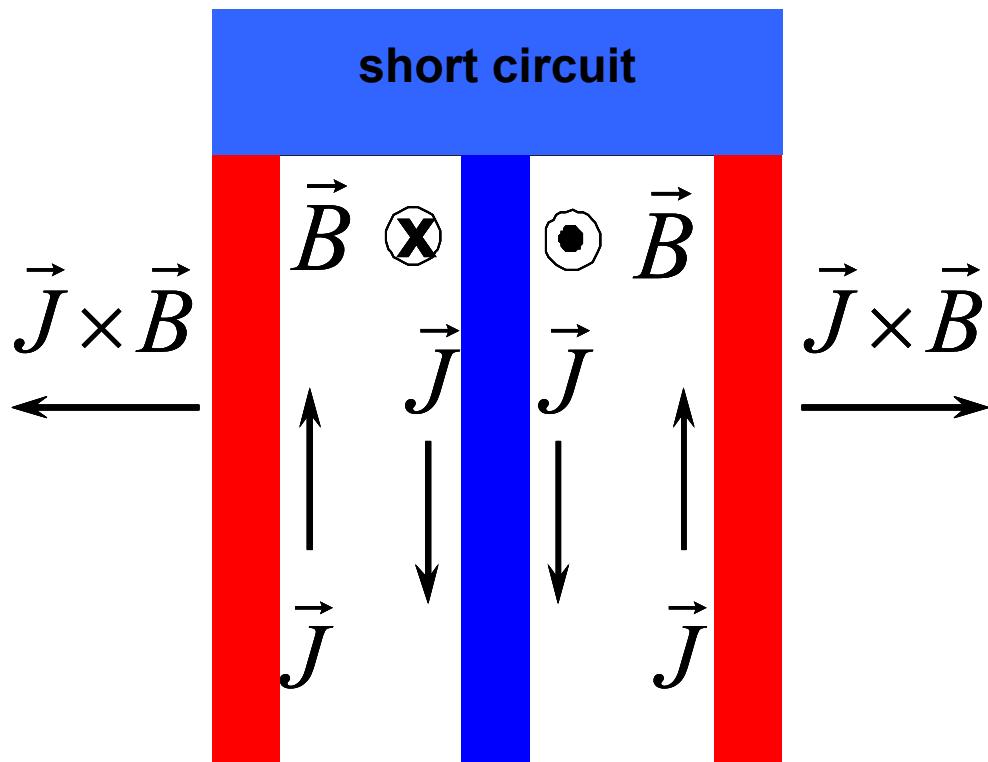


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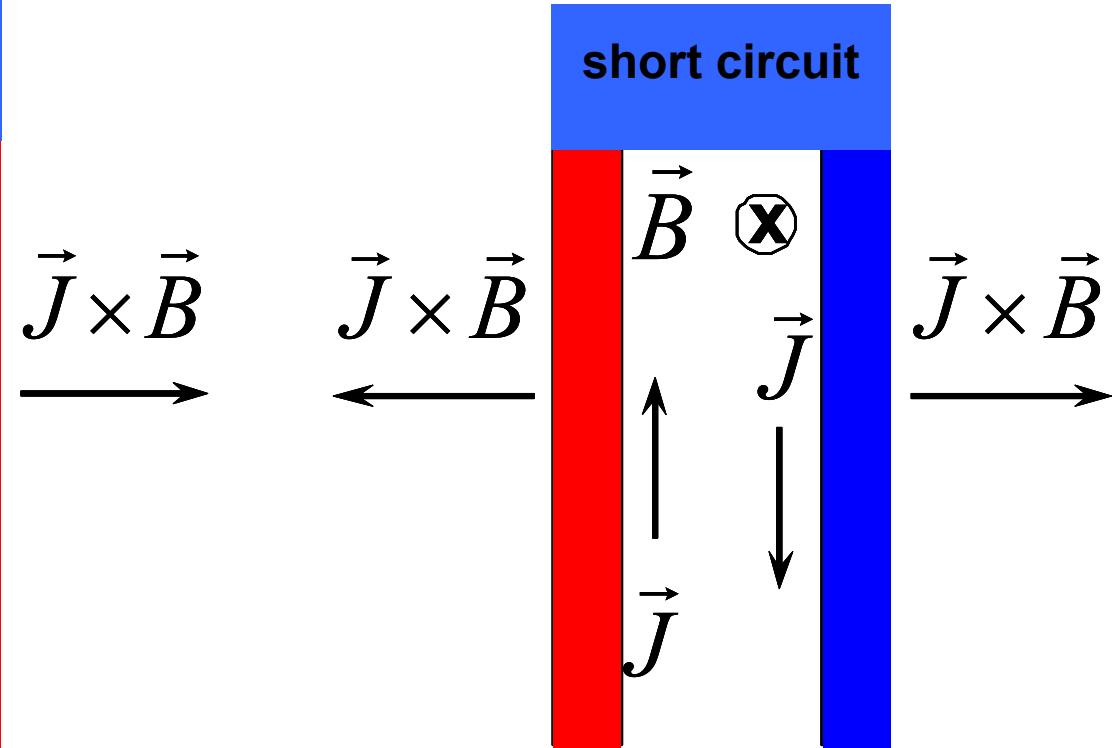


# Stripline enables two samples to experience identical B-field, ensuring identical pressure histories

## Co-axial



## Stripline



= anode



= cathode



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# Shock Compression

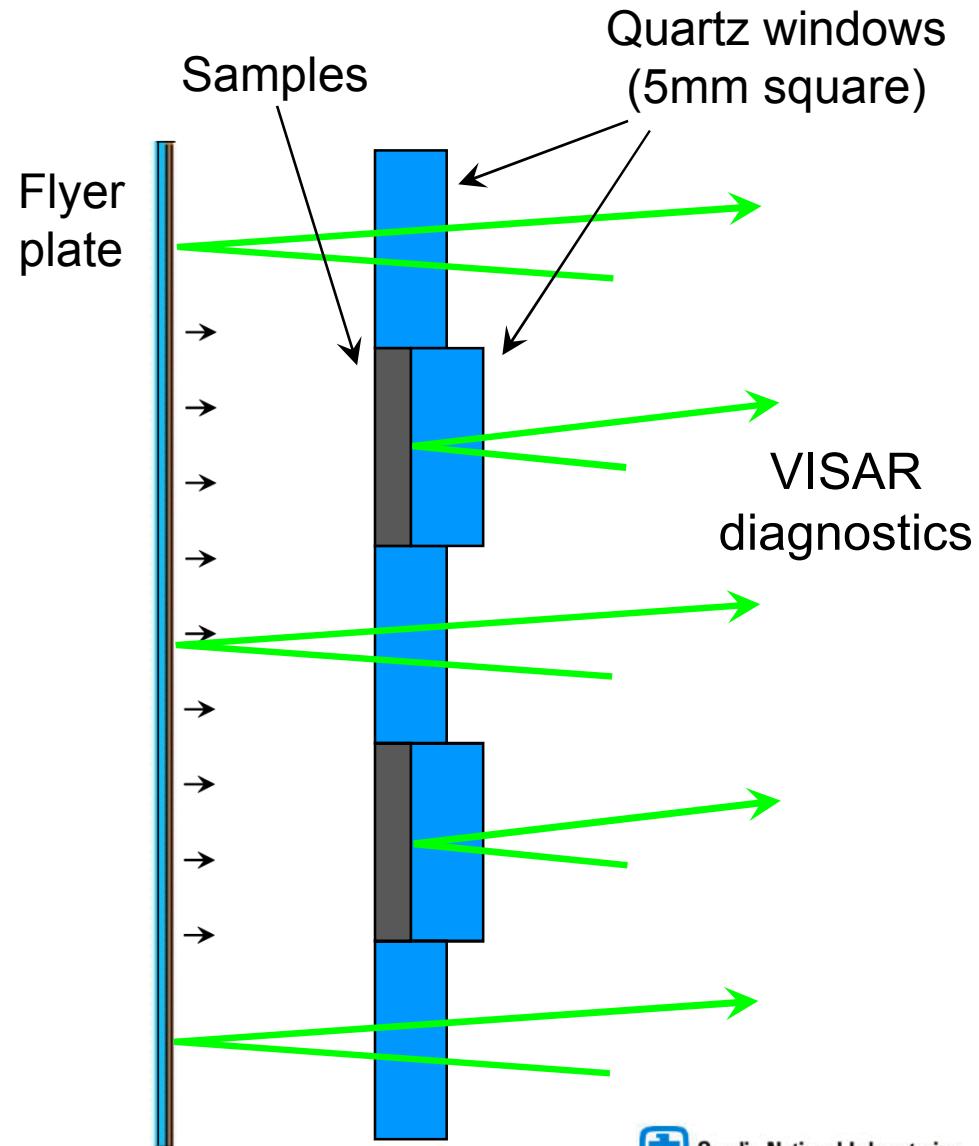
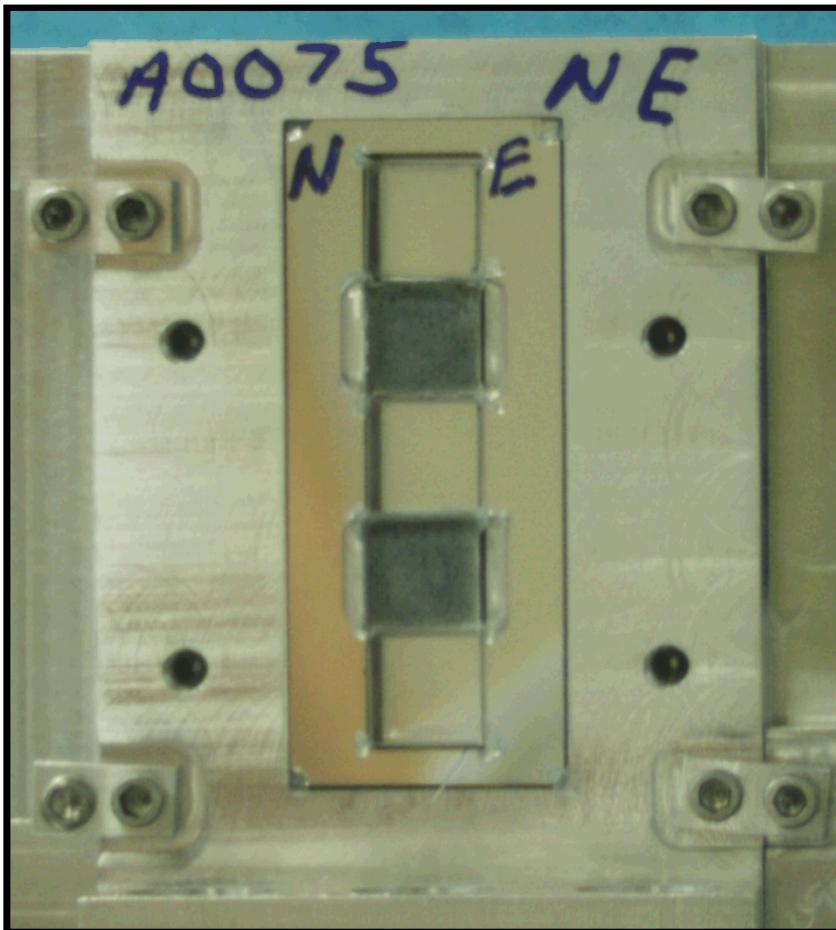
## “Typical” Capabilities

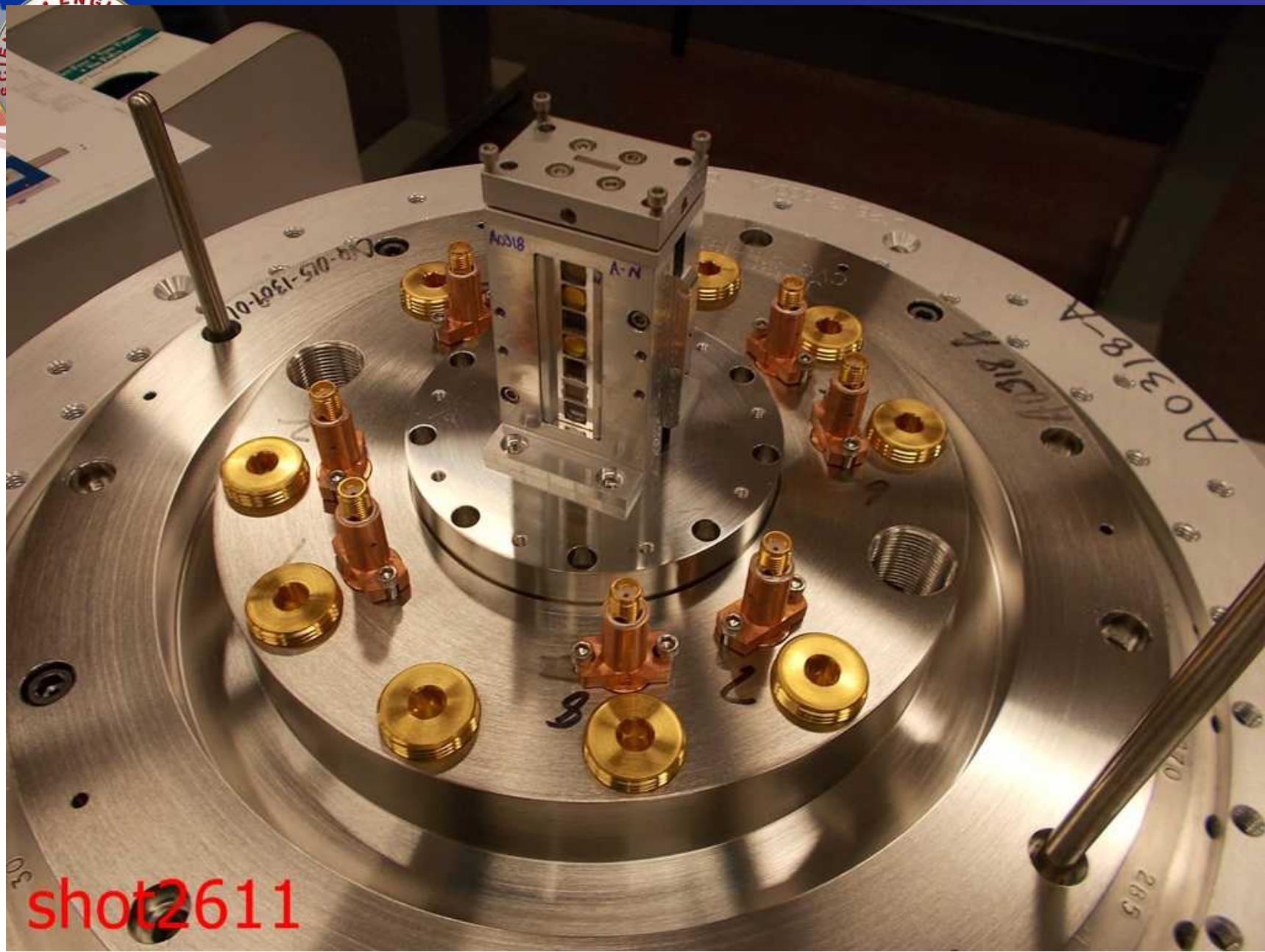
- 1.5 – 35 km/s flyers
- Aluminum or Copper flyers (~100 micron thick at solid density)
- Absolute Hugoniot or quartz impedance standard
- Coaxial or stripline geometry
- 5-7 sample positions per panel (10-14/shot)
- Asymmetric coax for two flyer velocities (one per panel, velocities coupled)
- Samples ~100's microns thick, 5-8 mm diameter or square
- Cryogenic targets (gas fill @ 10's psig)



# Quartz has been used as a transparent window enabling multiple flyer velocity measurements

Typical configuration



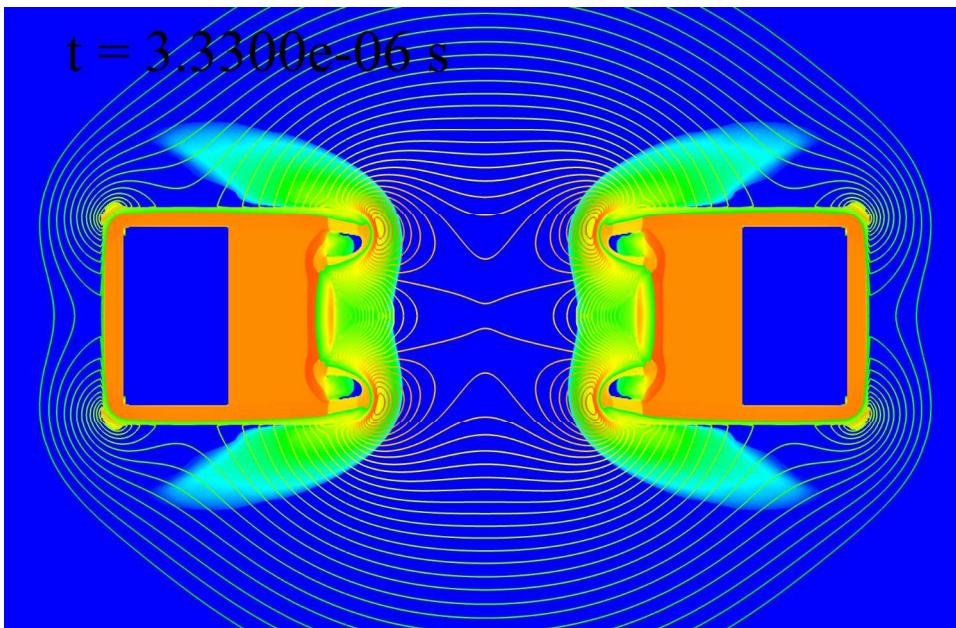


shot2611

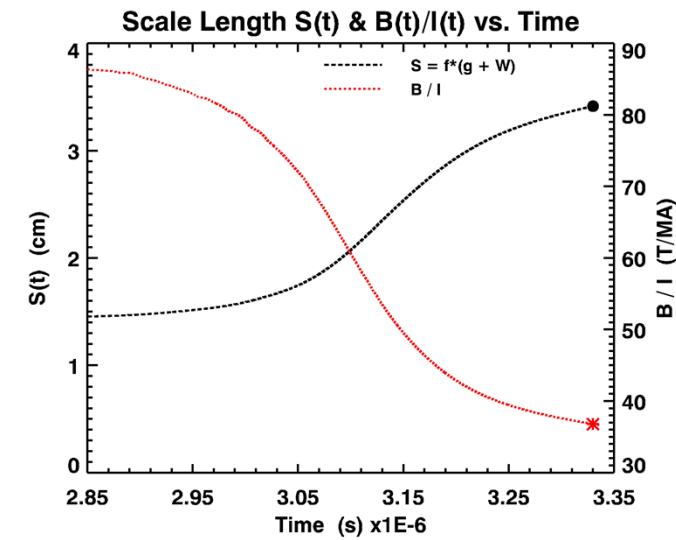
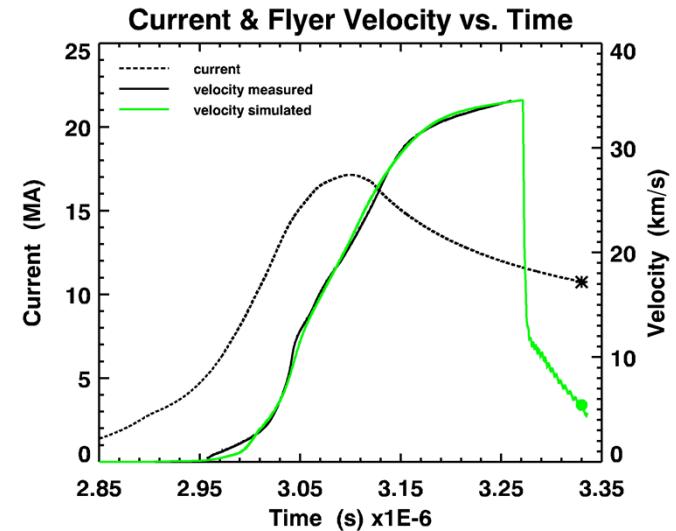


# A truly predictive MHD modeling capability has been developed over the last several years

Simulation 2-sided, 11 mm strip-line, 900  $\mu\text{m}$  Al flyers, density & magnetic field



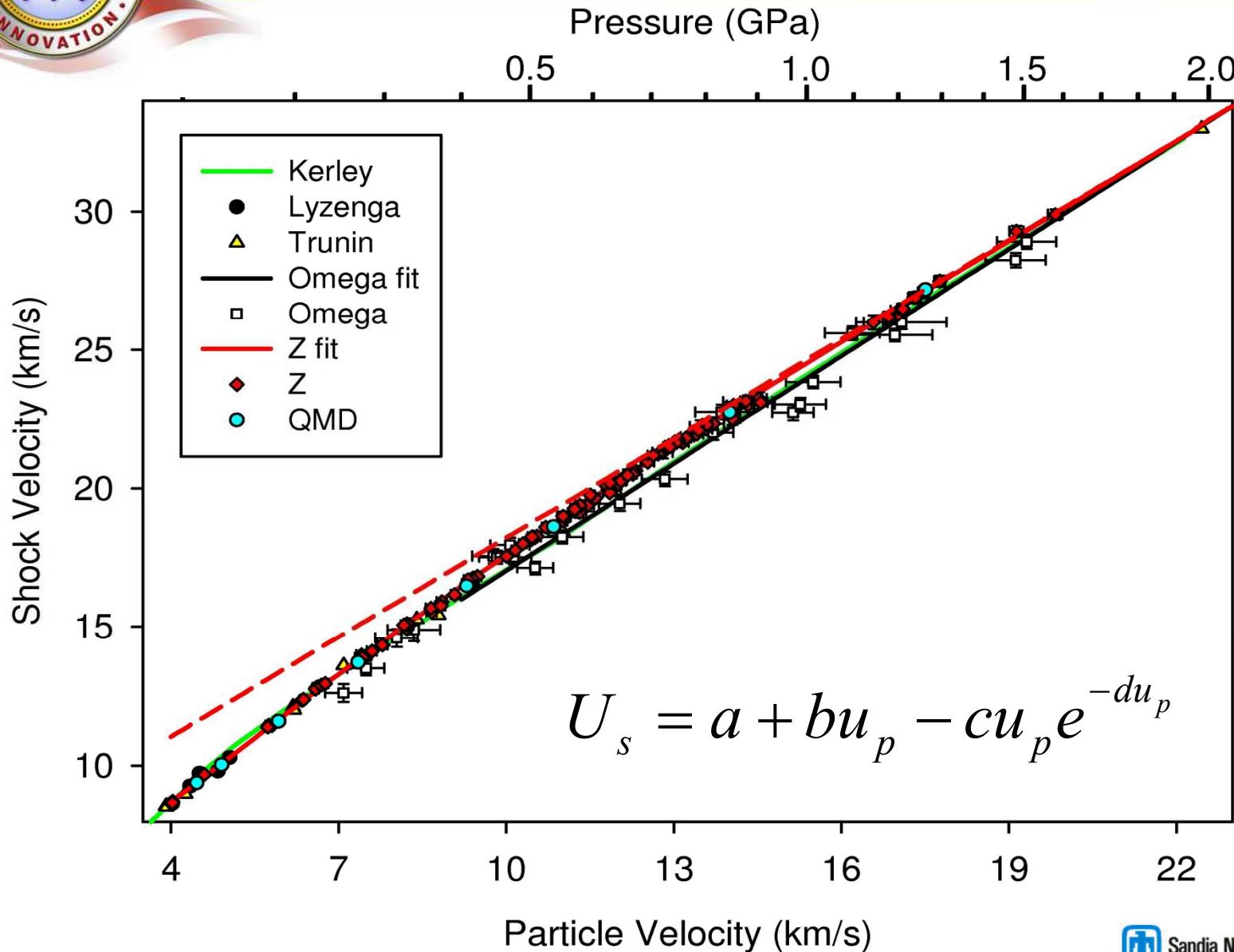
Agreement between simulation and experiment at the  $\sim 1\%$  level can be achieved



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# $U_s$ - $u_p$ Hugoniot for $\alpha$ -Quartz – over 200 points



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# Shock Platform Challenges

- Challenges are largely diagnostic/physics/sample based
  - Shock and/or particle velocities measured with high accuracy (principal Hugoniot is easiest/most accurate)
  - Database of design pulseshapes for many flyer velocities
- Sample procurement/quality
- Data interpretation for samples exhibiting complex phenomena (phase transitions, rate dependent phenomena, etc.)



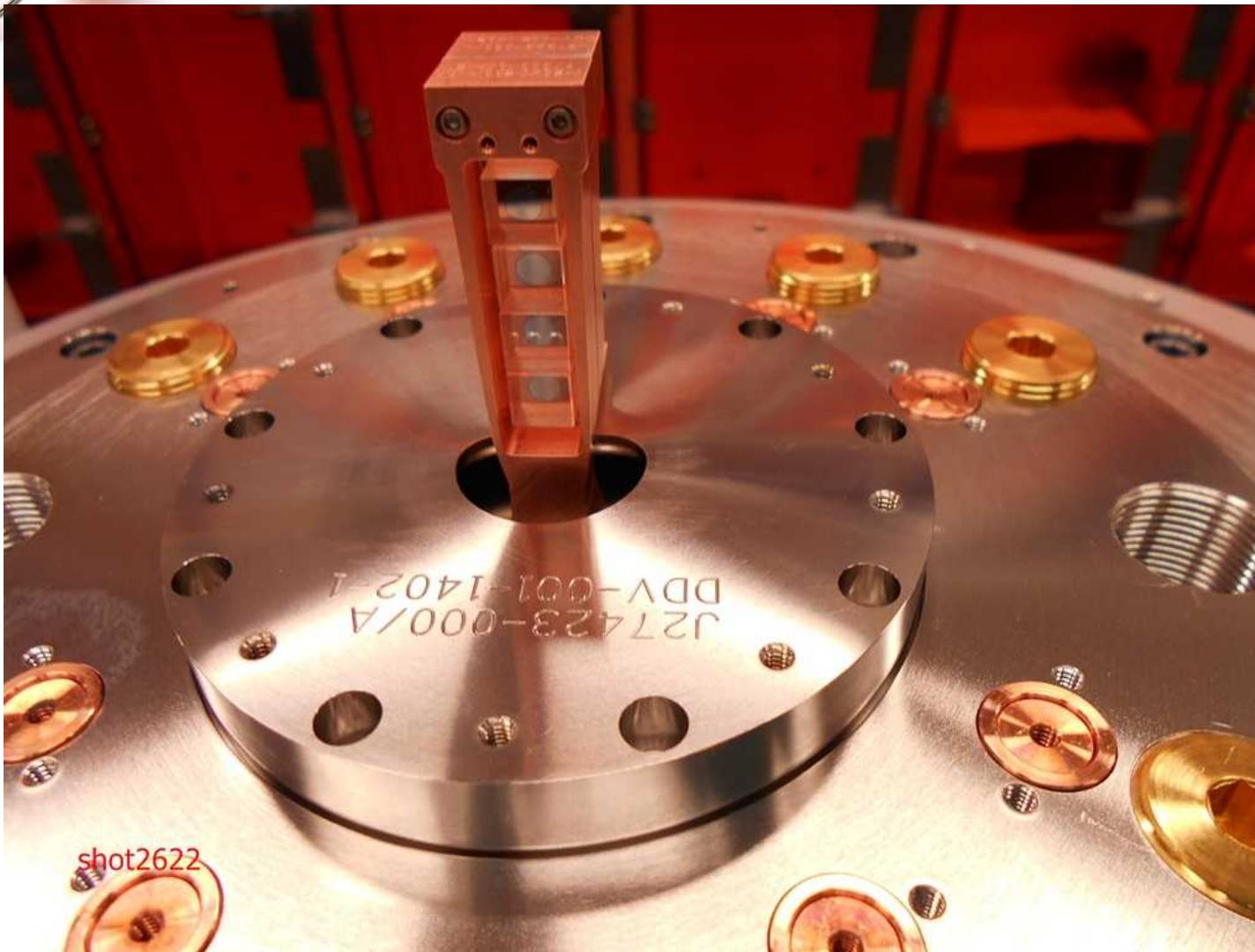
# Shockless (Ramp) Compression

## “Typical” Capabilities

- 500 – 1200 ns pulse length
- Aluminum or Copper electrodes
- Free surface or windowed samples
- Stripline geometry preferred (coax possible)
- 2-5 sample positions per panel (4-10/shot)
- Samples ~100's microns to few mm thick, 5-8 mm diameter or square
- Peak stresses highly dependent on sample material (~4 Mbar for high impedance, ~1-2 for low impedance)
- Experiments designed for EoS and/or Strength



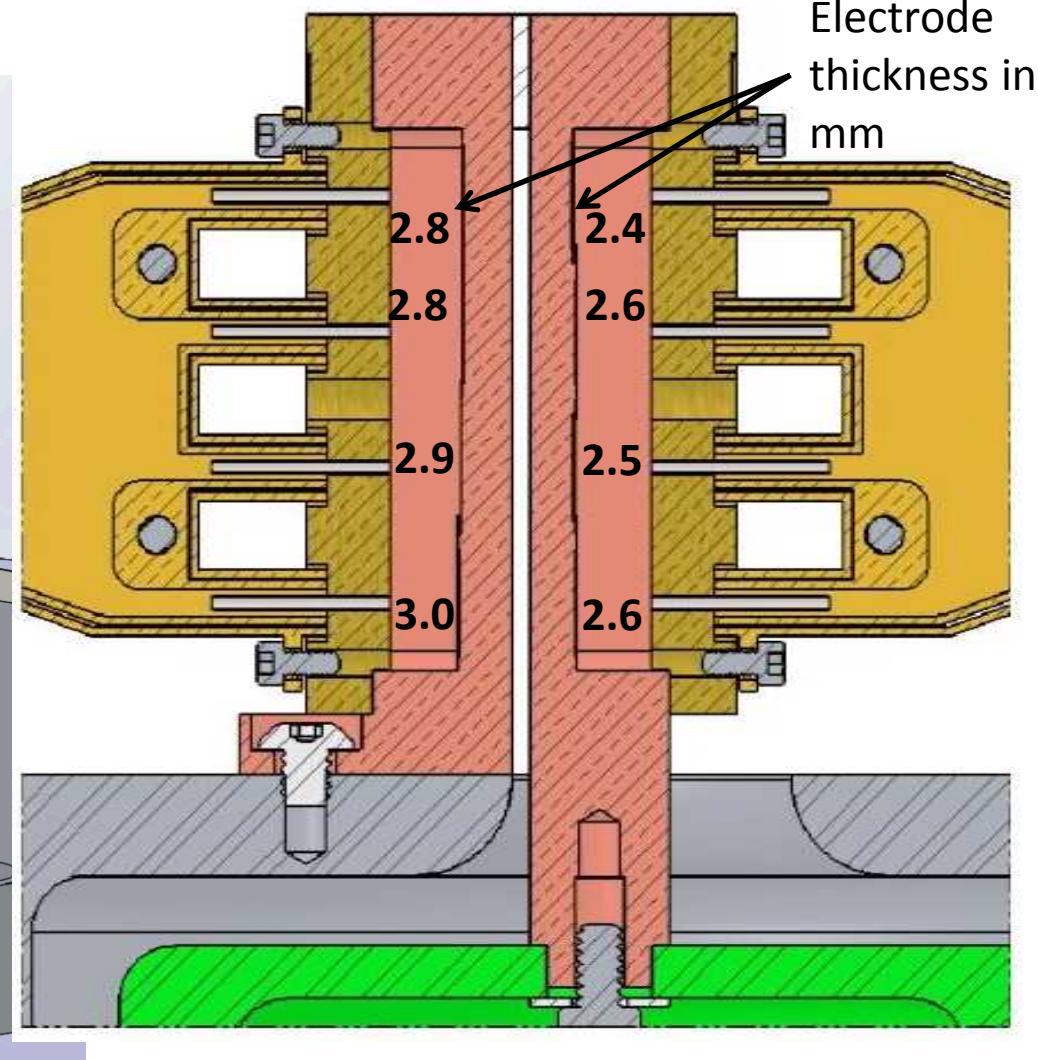
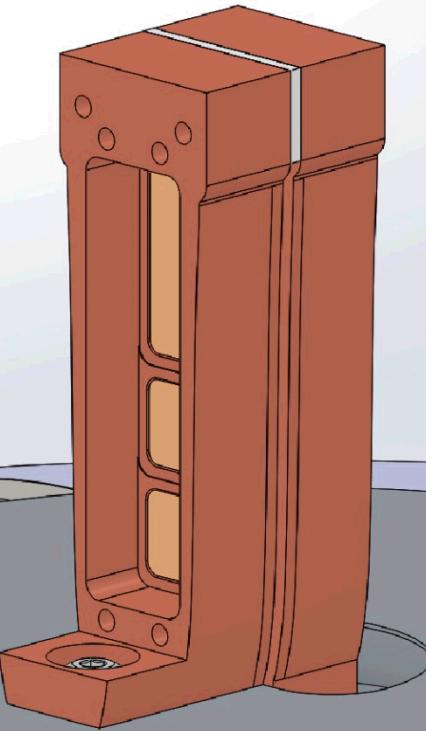
# Recent Stripline panels for Shockless Compression EoS



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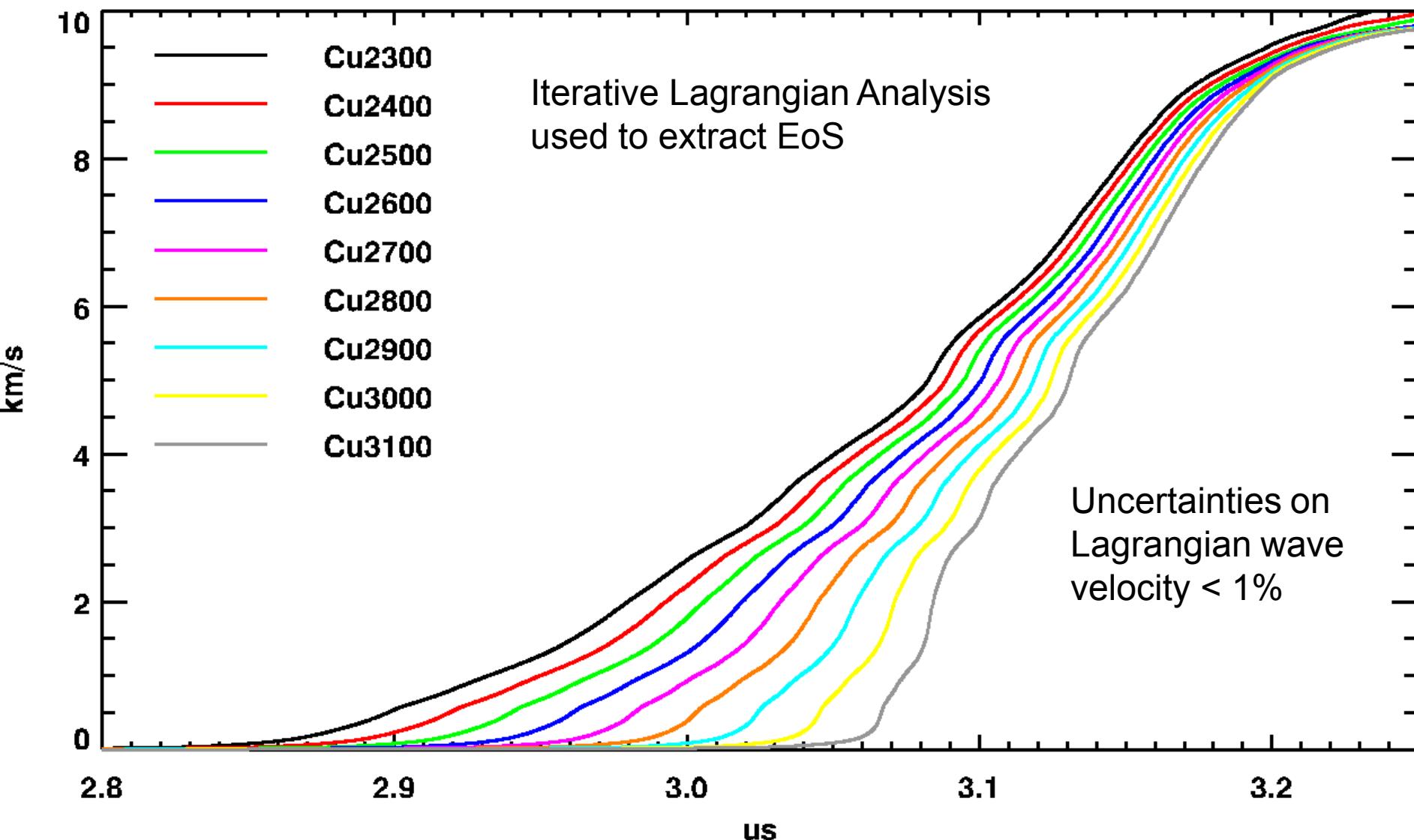
# Recent Hardware for Copper Ramp to ~4 Mbar



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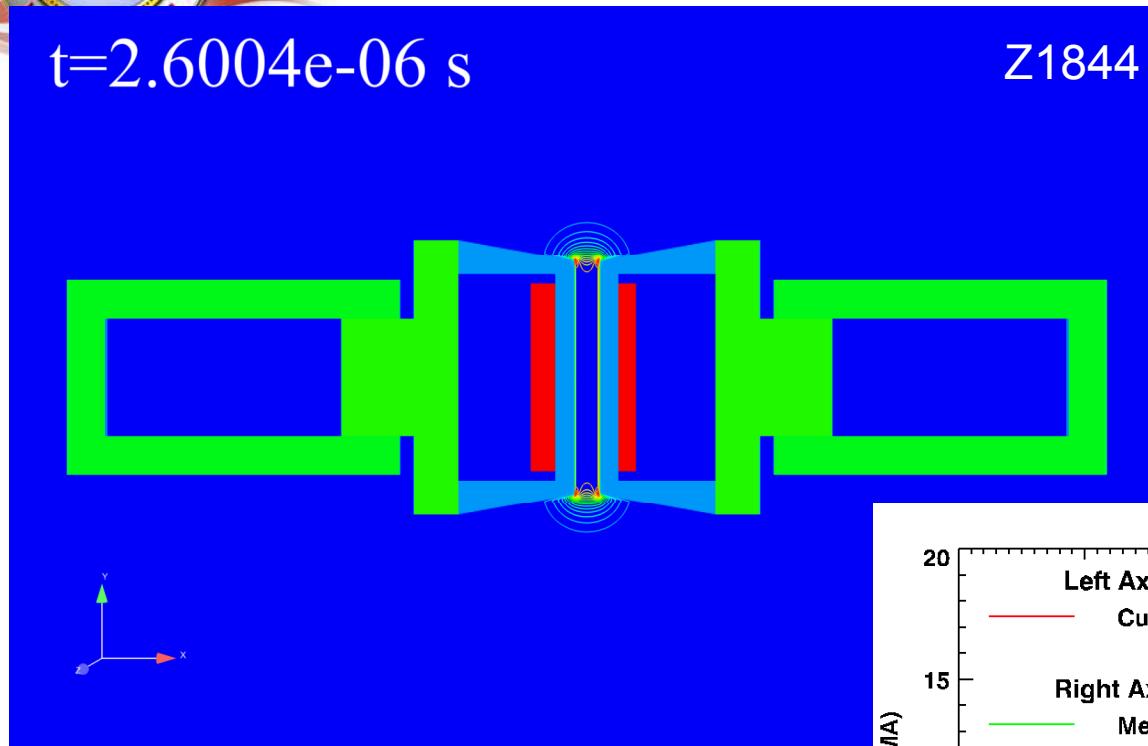


# Predicted Free Surface Velocities

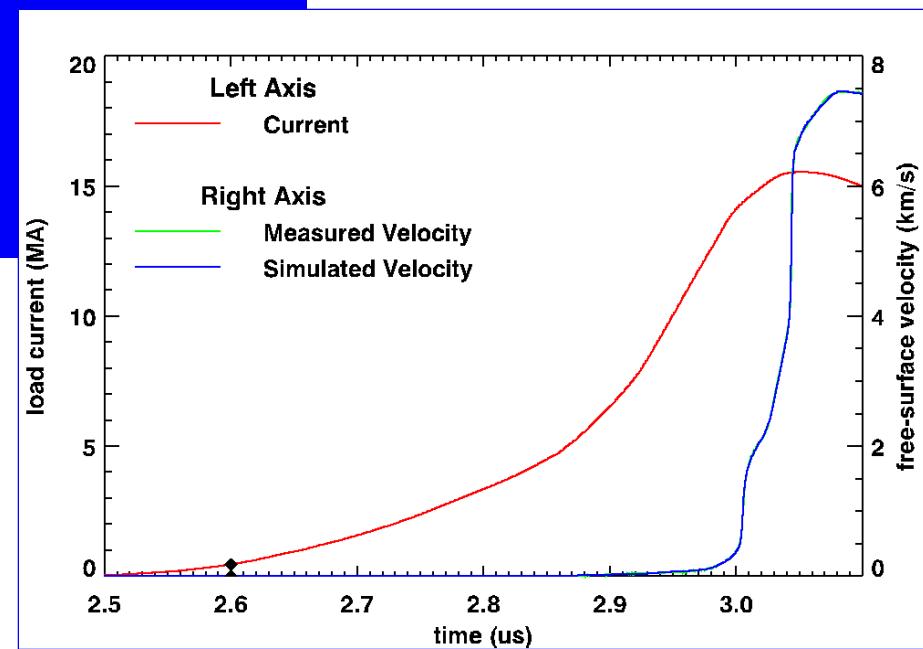




# Simulations predict highly uniform B-field in the lateral and normal directions over most of the gap



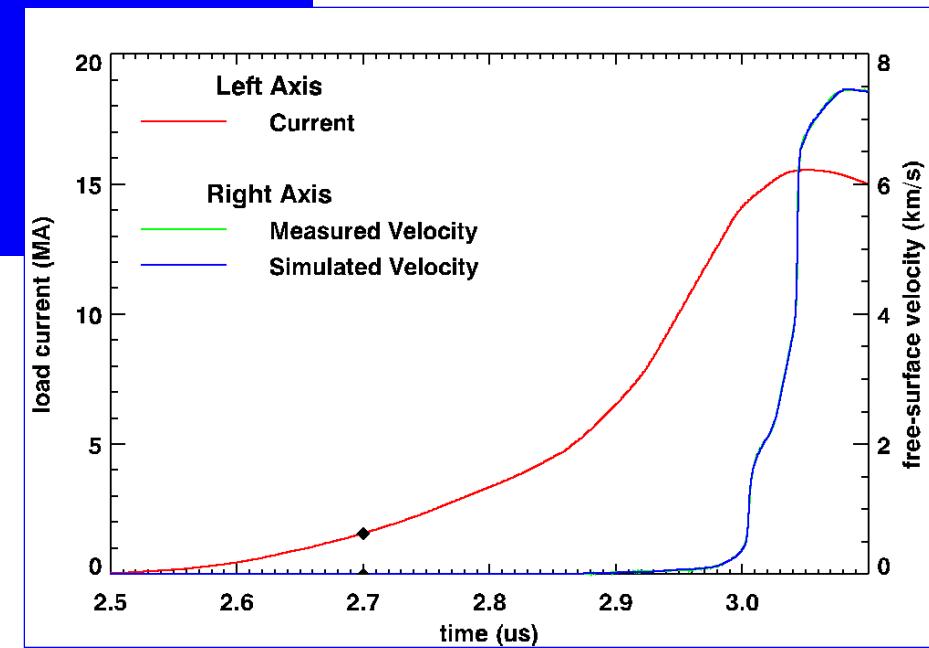
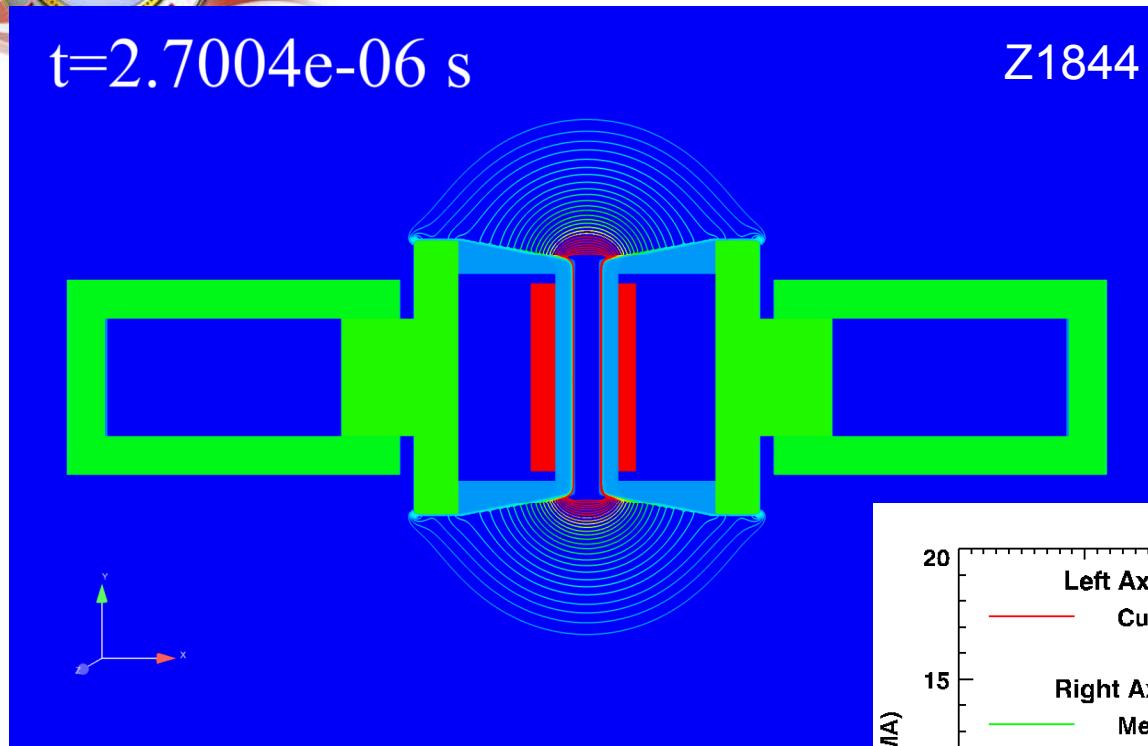
**2-D Alegra-MHD:**  
Resistive MHD  
QMD/LMD  
conductivity  
Sesame EOS  
Circuit model



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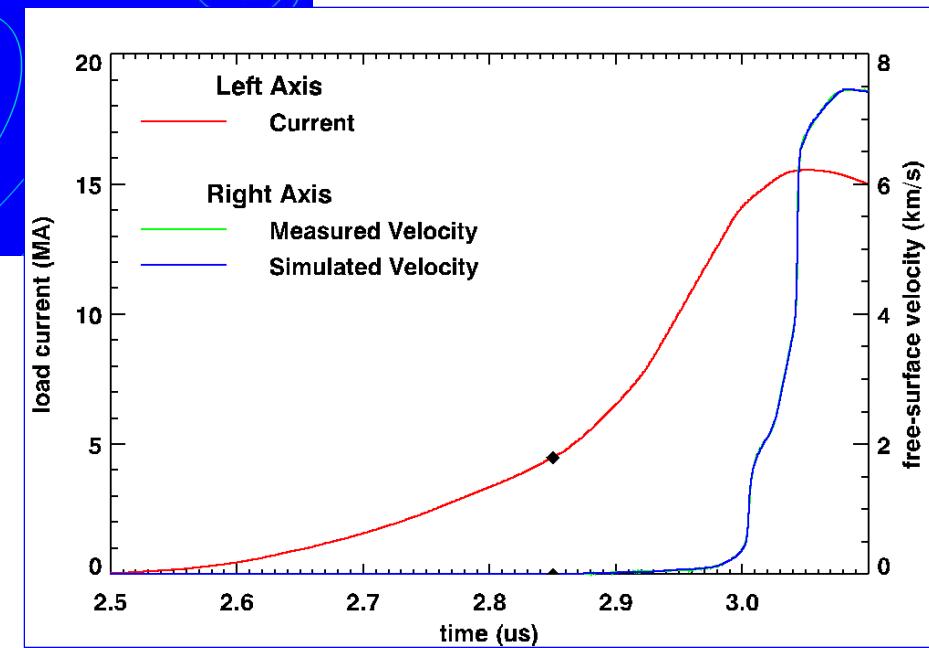
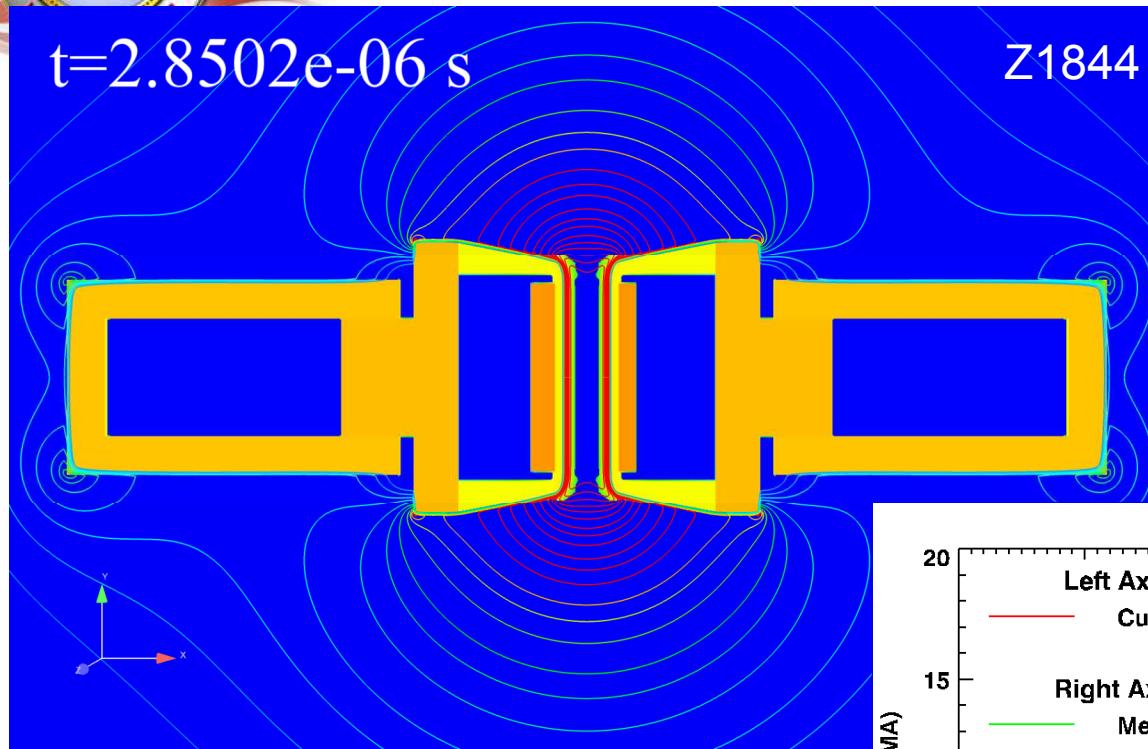
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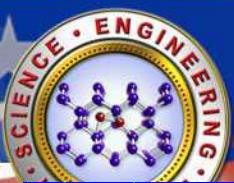
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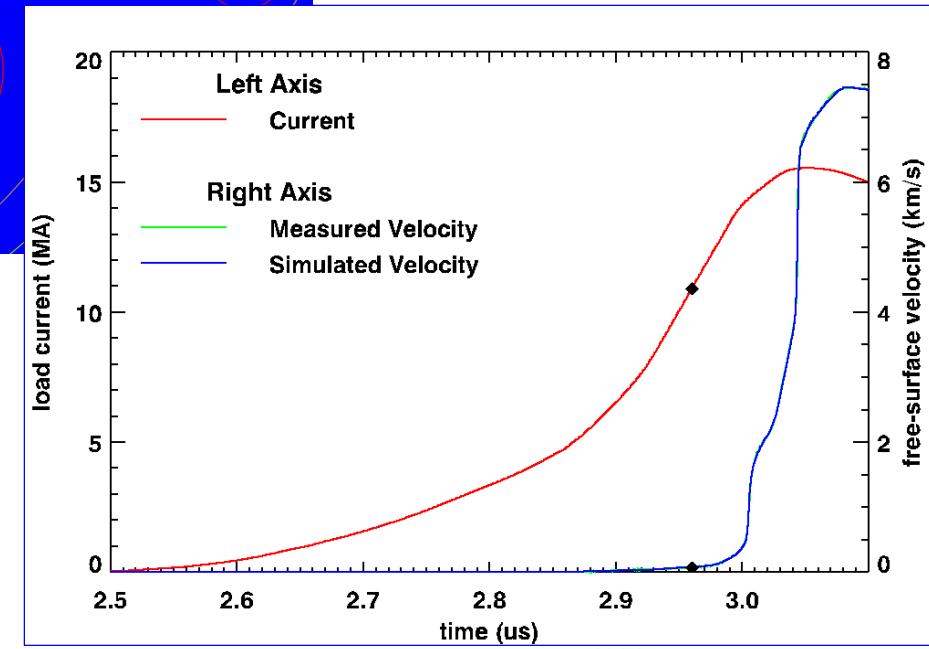
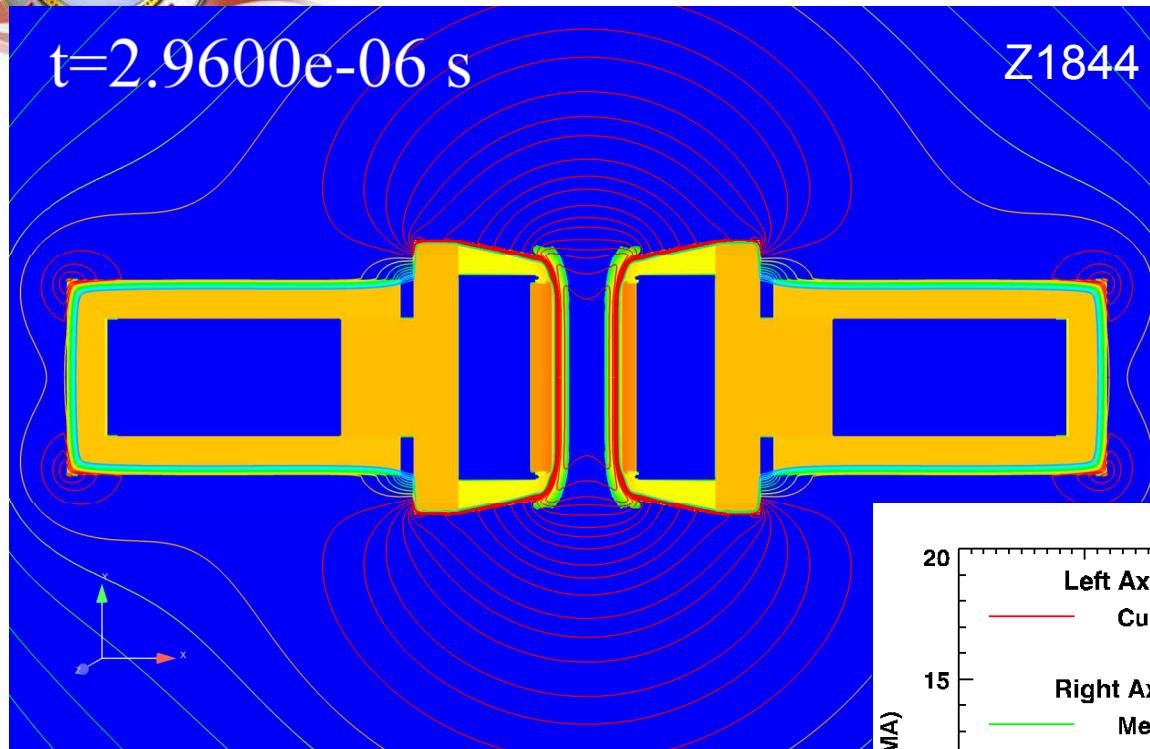
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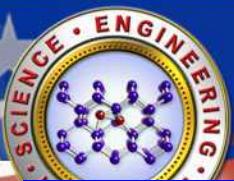
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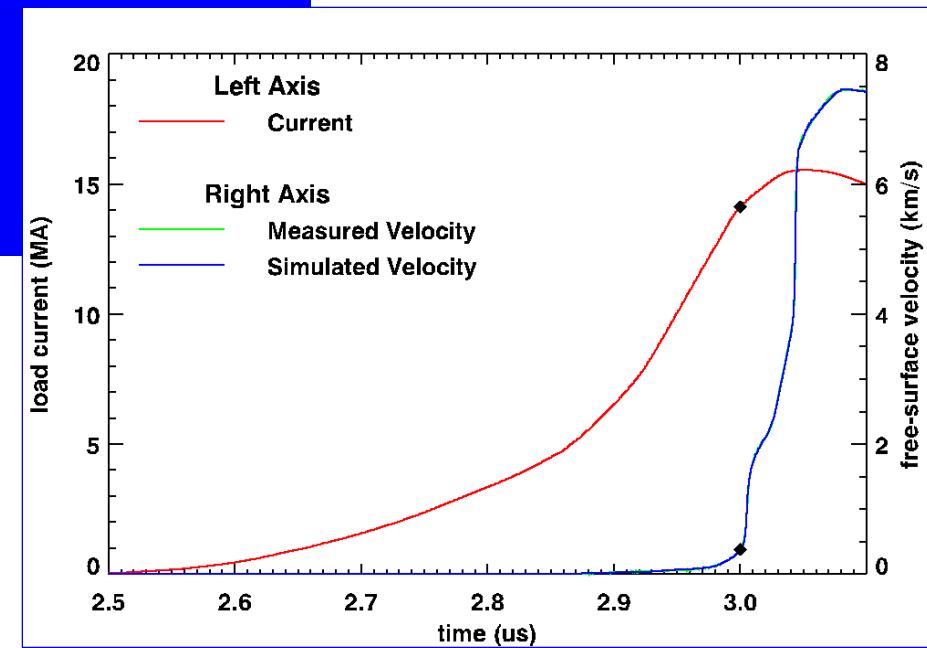
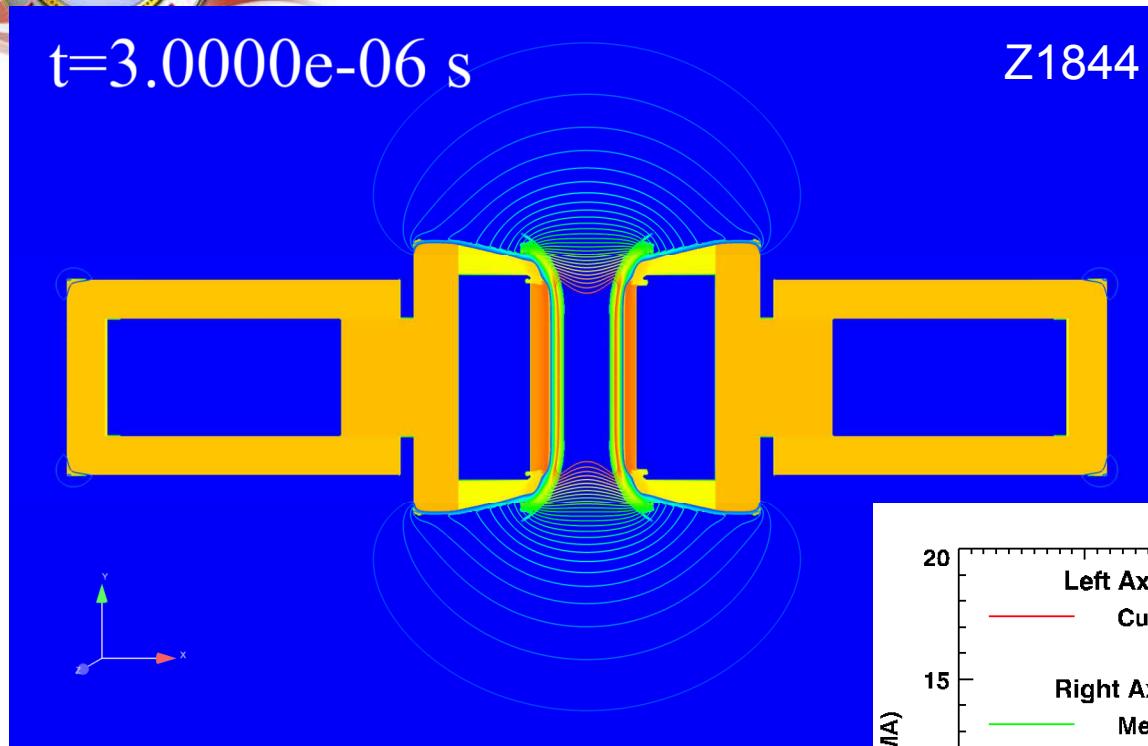
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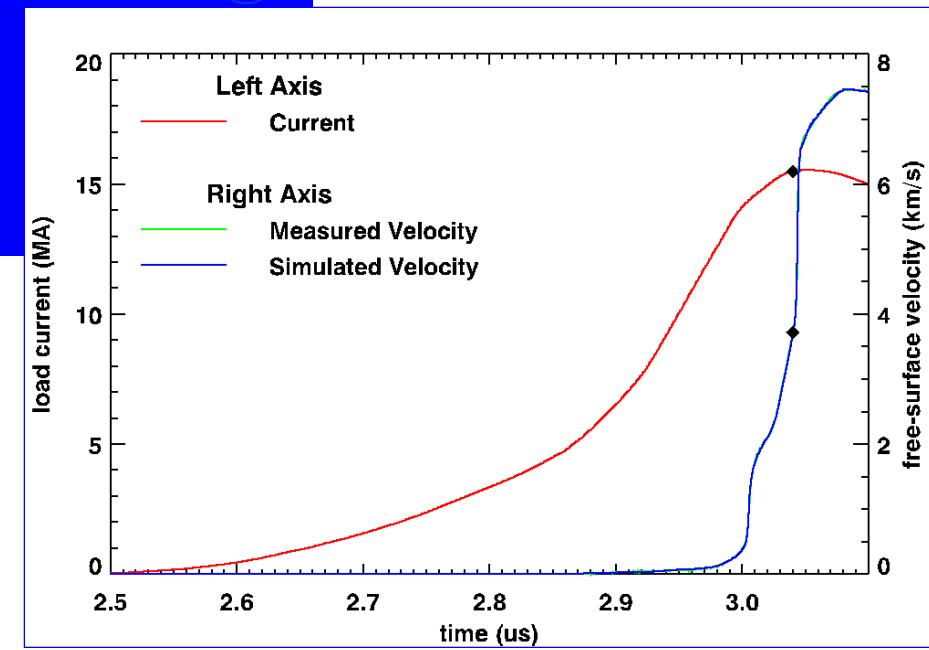
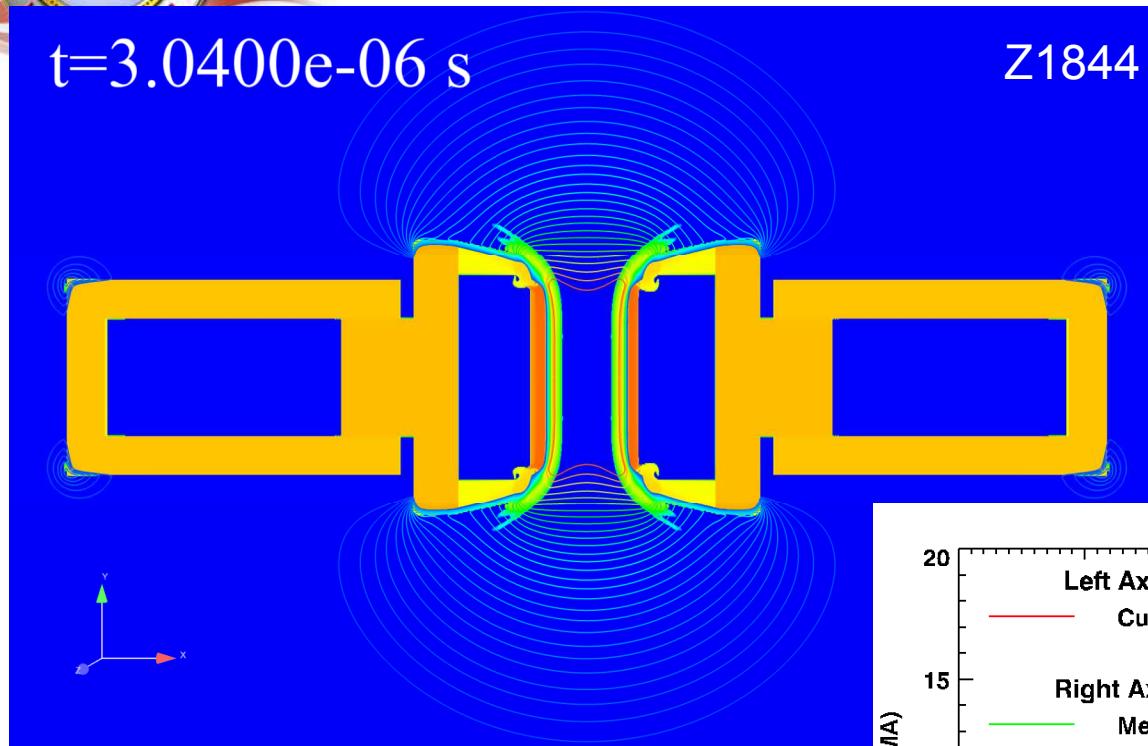
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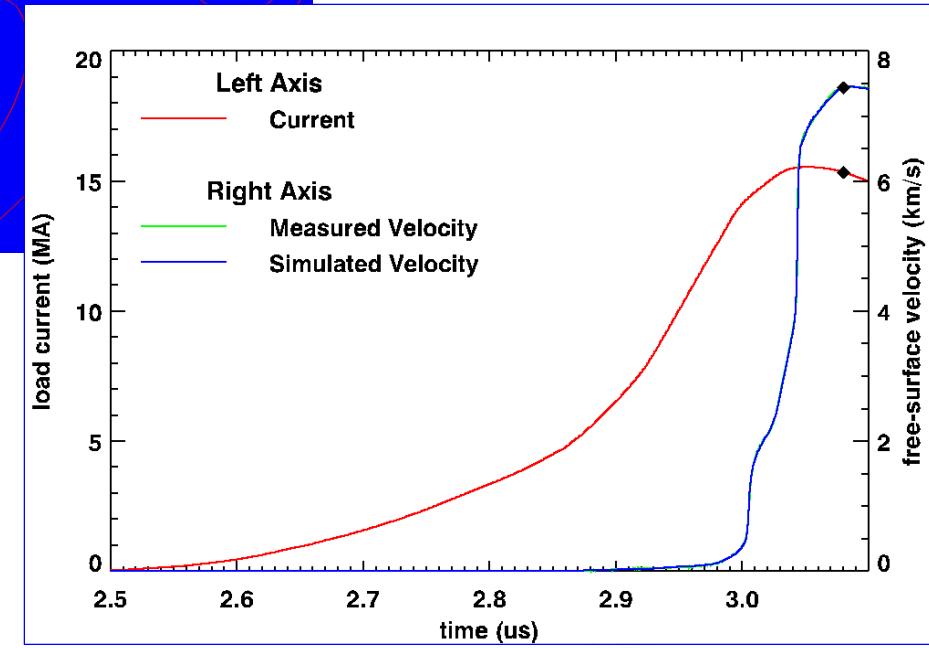
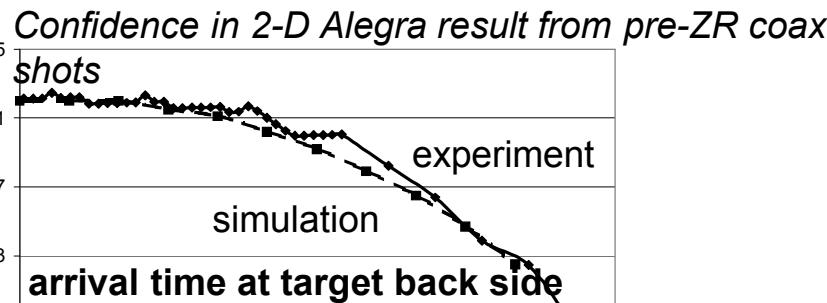
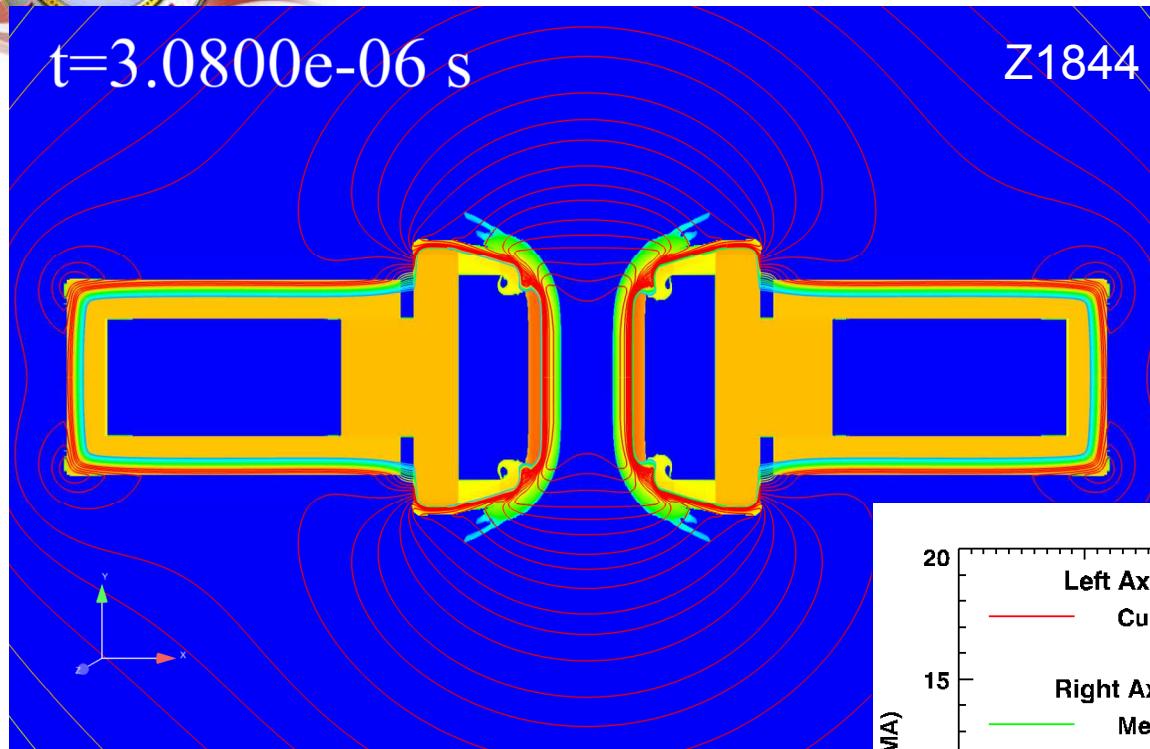
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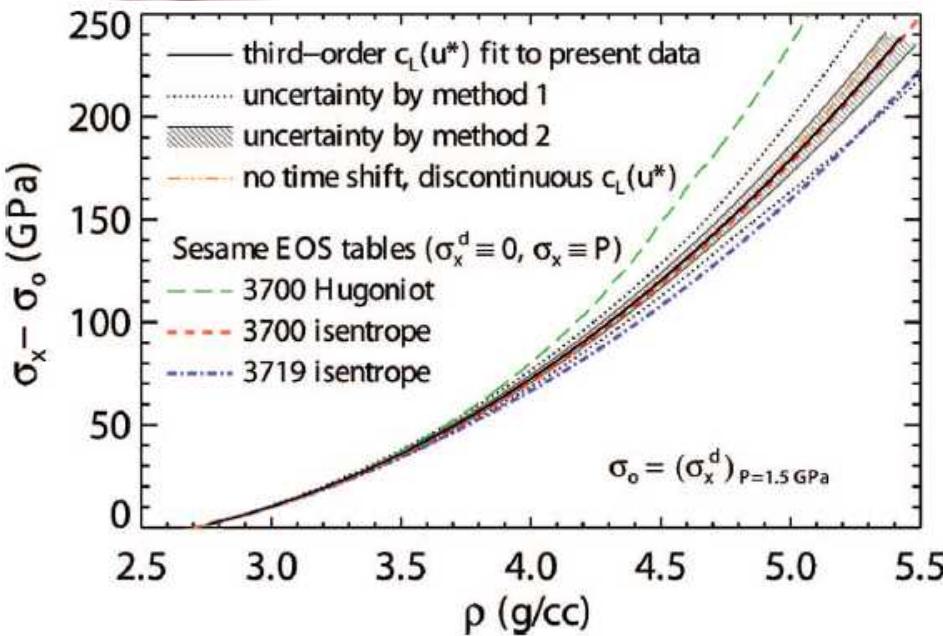
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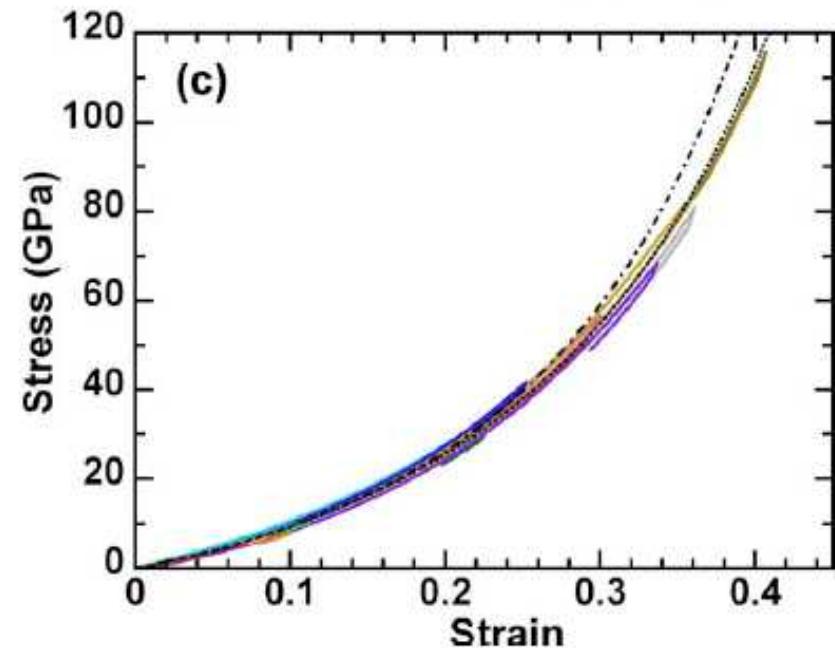


# High precision data may be used to discriminate models



Aluminum, Davis, JAP, 2006

LiF, Ao et al., JAP, 2009





# Shockless Compression Challenges

- Almost every experiment requires a new pulsedshape
- Experiment design requires a guess of the sample EoS
- Preventing shock-up vs delaying reverberation in sample
  - Assumptions in analysis techniques breakdown at time of reverberation
- Highest pressure data requires very accurate relative timing (currently <100 ps accuracy)
- Sample Quality
- Strength/EoS often coupled



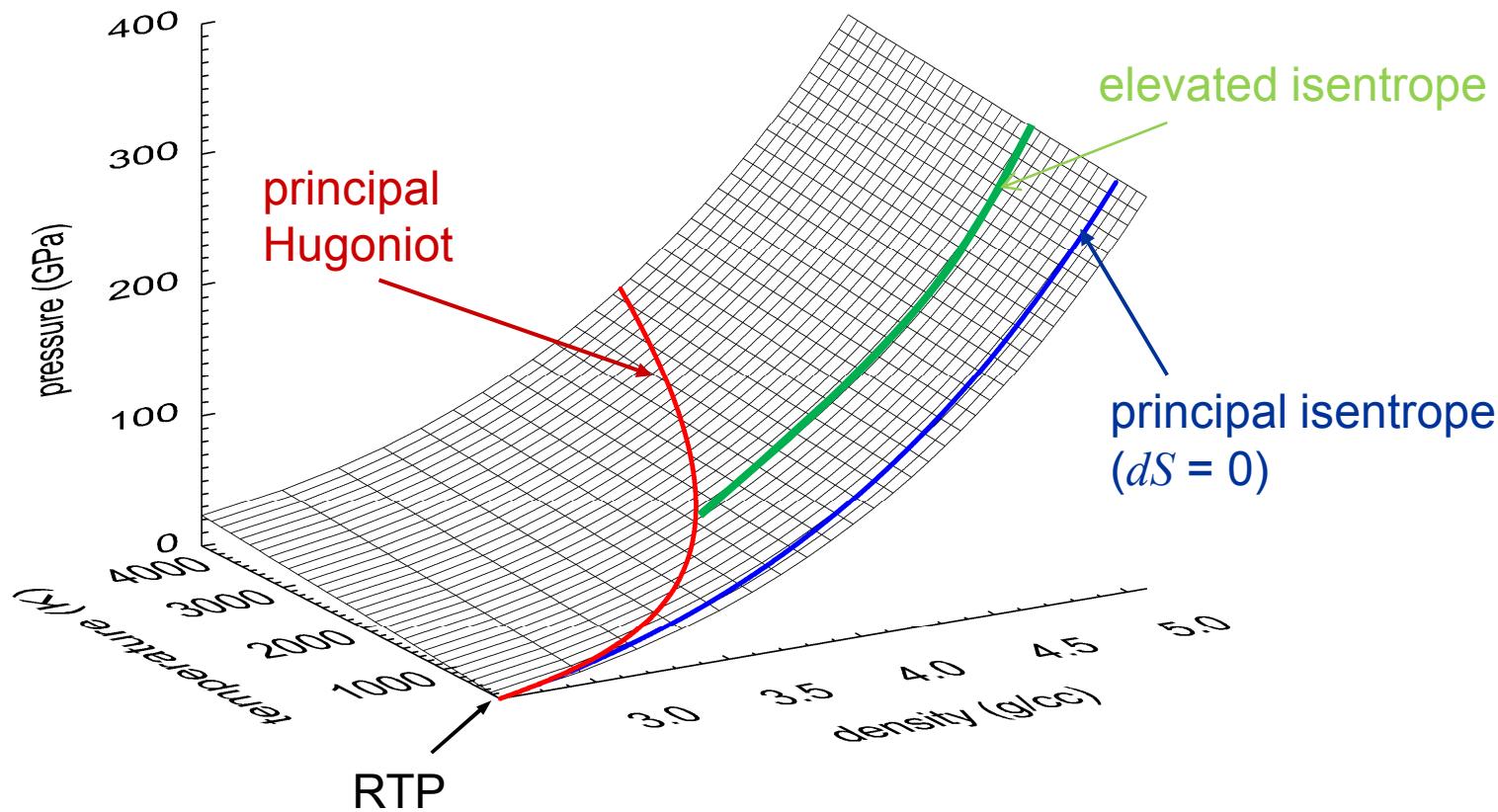
# Shock-Ramp

## “Typical” Capabilities

- 800 – 1200 ns pulse length (double-ramp)
- Aluminum or Copper electrodes
- Flyer velocity ~1.5 – 4.5 km/s
- Free surface or windowed samples
- Stripline geometry preferred (coax possible)
- 2-5 sample positions per panel (4-10/shot)
- Samples ~mm thick, 5-8 mm diameter or square
- Experiments designed for EoS

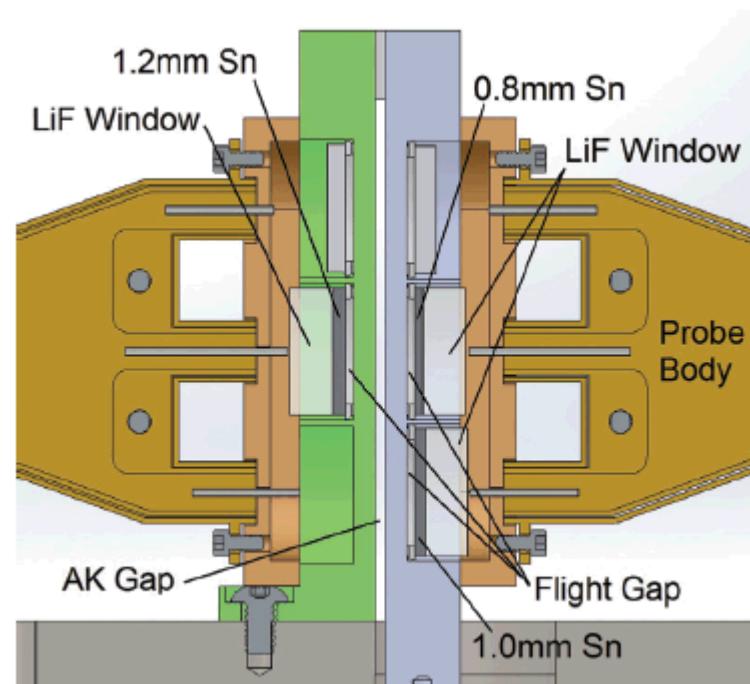
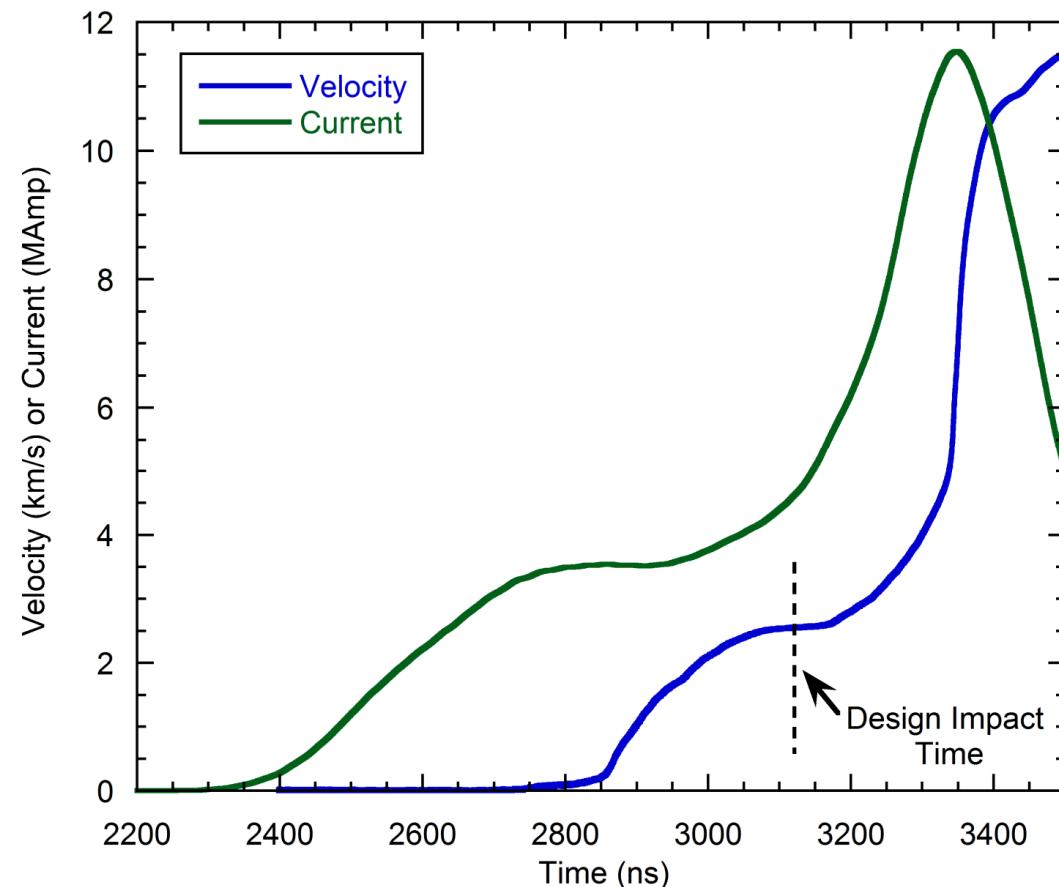


- Shock to a point on the Hugoniot – then ramp compress from this density/pressure
- Flyer accelerated to constant velocity – impact, then push harder



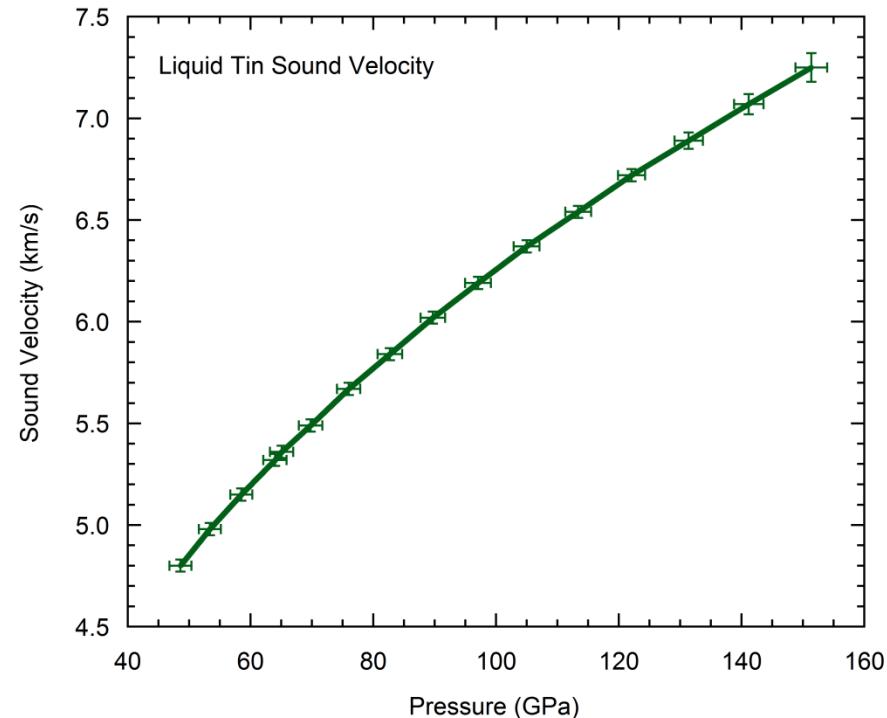
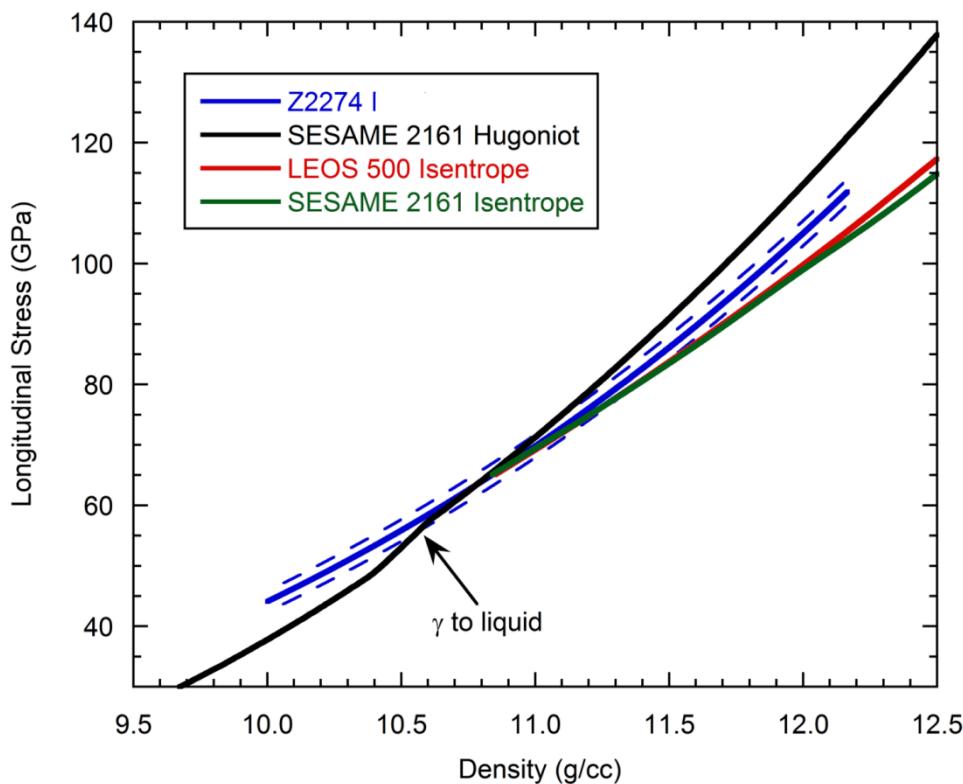


## Double-ramp pulseshape “holds” a Hugoniot state in the sample before ramping





# High accuracy EoS at elevated temperatures



Tin, Seagle et al., APL, 2013



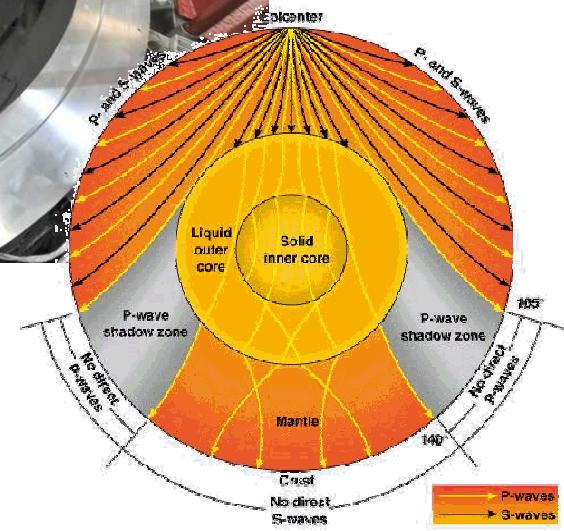
# Shock-Ramp Challenges

- Every experiment requires a new pulseshape
- EoS of sample must be guessed to design experiment
- Strong trade-off between peak stress, shocking up during ramp, and reverberation
- Significant machine energy used to accelerate the flyer – peak stress typically limited below shockless compression platform





# Z Provides Unique Opportunities for Planetary Science



High Accuracy Sound Velocities of Solid and Shock-Melted Materials

High Stress – High Entropy States

Slide Credits: Chris Seagle, Marcus Knudson, Jean-Paul Davis, Ray Lemke



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